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Application/Control No.	Applicant(s)/Patent under Reexamination
10/042,480	CHANG ET AL.
Examiner	Art Unit
Liang-che Alex Wang	2155

SEARCHED			
Class	Subclass	Date	Examiner
707	1-10, 100- 104.1, 200-205	8/29/2007	LW
709	232, 242	8/29/2007	LW

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
updated EAST search: USPUB, EPO, JPo, DERWENT	8/29/2007	LW
NPL search: Google	8/29/2007	LW
consulted with Lynne Browne	8/29/2007	LW